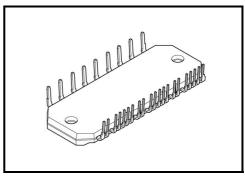
**TOSHIBA Intelligent Power Module** 

# **MIG10J503H**

MIG10J503H is an intelligent power module for three-phase inverter system. The 4th generation low saturation voltage trench gate IGBT and FRD are connected to a three-phase full bridge type, and IC by the original high-voltage SOI (silicon-on-insulator) process drives these directly in response to a PWM signal. Moreover, since high-voltage level-shifter is built in high-voltage IC, while being able to perform a direct drive without the interface with which the upper arm IGBT is insulated, the drive power supply of an upper arm can be driven with a bootstrap system, and the simplification of a system is possible. Furthermore, each lower arm emitter terminal has been independent so that detection can perform current detection at the time of vector control by current detection resistance of a lower arm. The protection function builds in Under Voltage



Weight: 18 g (typ.)

Protection, Short Circuit Protection, and Over Temperature Protection. Original high thermal conduction resin is adopted as a package, and low heat resistance is realized.

#### **Features**

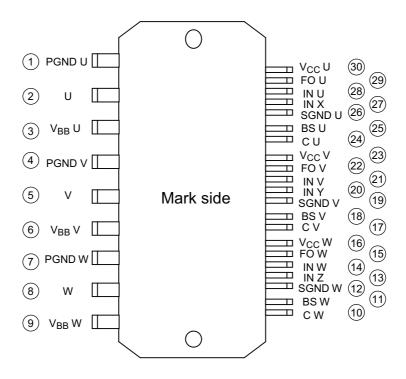
- The 4th generation trench gate thin wafer NPT IGBT is adopted.
- FRD is built in.
- The level shift circuit by high-voltage IC is built in.
- The simplification of a high side driver power supply is possible by the bootstrap system.
- Short circuit protection, over temperature protection, and the power supply under voltage protection function are built in.
- Short circuit protection and over temperature protection state are outputted.
- The lower arm emitter terminal has been independent by each phase for the purpose of the current detection at the time of vector control.

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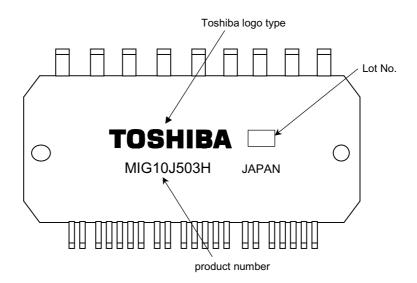
• Low thermal resistance by adoption of original high thermal conduction resin.

Since this product is MOS structure, it should be careful of static electricity in the case of handling.

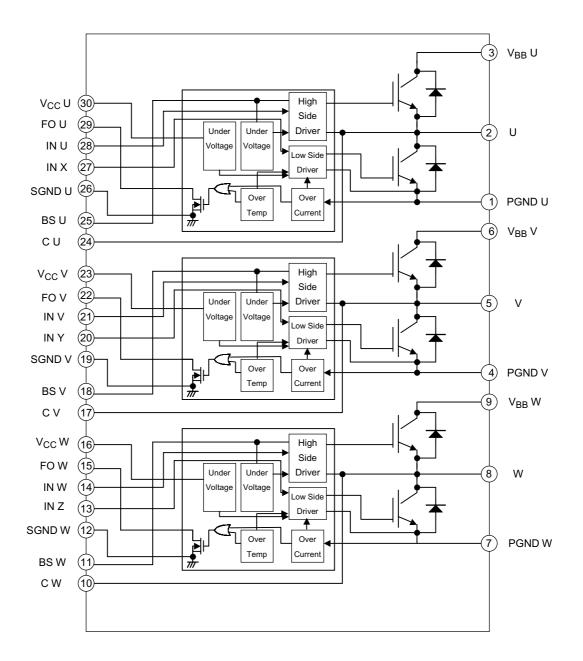
### **Pin Assignment**



## Marking



### **Block Diagram**



MIG10J503H



# **Pin Description**

Pin No.	Symbol	Pin Description		
1	PGND U	U-Phase Power Ground pin (connect a current detecting resistor between this pin and SGND U pin)		
2	U	U-Phase output pin		
3	V <sub>BB</sub> U	U-Phase high-voltage power supply pin		
4	PGND V	/-Phase Power Ground pin (connect a current detecting esistor between this pin and SGND V pin)		
5	V	-Phase output pin		
6	V <sub>BB</sub> V	V-Phase high-voltage power supply pin		
7	PGND W	W-Phase Power Ground pin (connect a current detecting resistor between this pin and SGND W pin)		
8	W	W-Phase output pin		
9	V <sub>BB</sub> W	W-Phase high-voltage power supply pin		
10	C W	W-Phase bootstrap capacitor connecting pin (–)		
11	BS W	W-Phase bootstrap capacitor connecting pin (+)		
12	SGND W	W-Phase Signal Ground pin		
13	IN Z	W-Phase low-side input pin (negative logic)		
14	IN W	W-Phase high-side input pin (negative logic)		
15	FO W	W-Phase Diagnosis output pin (open drain output. Wired or connection can be performed with the diagnosis output pin of other phase.)		
16	V <sub>CC</sub> W	W-Phase control power supply (+15 V typ.)		
17	CV	V-Phase bootstrap capacitor connecting pin (-)		
18	BS V	V-Phase bootstrap capacitor connecting pin (+)		
19	SGND V	V-Phase Signal Ground pin		
20	IN Y	V-Phase low-side input pin (negative logic)		
21	IN V	V-Phase high-side input pin (negative logic)		
22	FO V	V-Phase Diagnosis output pin (open drain output. Wired or connection can be performed with the diagnosis output pin of other phase.)		
23	V <sub>CC</sub> V	V-Phase control power supply (+15 V typ.)		
24	CU	U-Phase bootstrap capacitor connecting pin (-)		
25	BS U	U-Phase bootstrap capacitor connecting pin (+)		
26	SGND U	U-Phase Signal Ground pin		
27	IN X	U-Phase low-side input pin (negative logic)		
28	IN U	U-Phase high-side input pin (negative logic)		
29	FO U	U-Phase Diagnosis output pin (open drain output. Wired or connection can be performed with the diagnosis output pin of other phase.)		
30	V <sub>CC</sub> U	U-Phase control power supply (+15 V typ.)		

#### **Truth Table**

Protection Circuit Detection State			Input		IGBT State		Fault Output	
High Side Under Voltage	Low Side Under Voltage	Short Circuit	Over Temperature	IN (X) High Side Arm	IN (X) Low Side Arm	High Side Arm	Low Side Arm	FO (X)
Un-Detecting	Un-Detecting	Un-Detecting	Un-Detecting	Н	Н	OFF	OFF	OFF
Un-Detecting	Un-Detecting	Un-Detecting	Un-Detecting	Н	L	OFF	ON	OFF
Un-Detecting	Un-Detecting	Un-Detecting	Un-Detecting	لـ	Н	ON	OFF	OFF
Un-Detecting	Un-Detecting	Un-Detecting	Un-Detecting	L	L	OFF	OFF	OFF
Detecting	Un-Detecting	Un-Detecting	Un-Detecting	Н	Н	OFF	OFF	OFF
Detecting	Un-Detecting	Un-Detecting	Un-Detecting	Н	L	OFF	OFF	OFF
Detecting	Un-Detecting	Un-Detecting	Un-Detecting	L	Н	OFF	OFF	OFF
Detecting	Un-Detecting	Un-Detecting	Un-Detecting	L	٦	OFF	OFF	OFF
Un-Detecting	Detecting	Un-Detecting	Un-Detecting	Н	Н	OFF	OFF	OFF
Un-Detecting	Detecting	Un-Detecting	Un-Detecting	Н	L	OFF	OFF	OFF
Un-Detecting	Detecting	Un-Detecting	Un-Detecting	L	Н	OFF	OFF	OFF
Un-Detecting	Detecting	Un-Detecting	Un-Detecting	L	L	OFF	OFF	OFF
Detecting	Detecting	Un-Detecting	Un-Detecting	Н	Н	OFF	OFF	OFF
Detecting	Detecting	Un-Detecting	Un-Detecting	Н	L	OFF	OFF	OFF
Detecting	Detecting	Un-Detecting	Un-Detecting	L	Н	OFF	OFF	OFF
Detecting	Detecting	Un-Detecting	Un-Detecting	L	L	OFF	OFF	OFF
Un-Detecting	Un-Detecting	Detecting	Un-Detecting	Н	Н	OFF	OFF	ON
Un-Detecting	Un-Detecting	Detecting	Un-Detecting	Н	L	OFF	OFF	ON
Un-Detecting	Un-Detecting	Detecting	Un-Detecting	L	Н	OFF	OFF	ON
Un-Detecting	Un-Detecting	Detecting	Un-Detecting	L	L	OFF	OFF	ON
Un-Detecting	Un-Detecting	Un-Detecting	Detecting	Н	Н	OFF	OFF	ON
Un-Detecting	Un-Detecting	Un-Detecting	Detecting	Н	L	OFF	OFF	ON
Un-Detecting	Un-Detecting	Un-Detecting	Detecting	L	Н	OFF	OFF	ON
Un-Detecting	Un-Detecting	Un-Detecting	Detecting	L	L	OFF	OFF	ON
Un-Detecting	Un-Detecting	Detecting	Detecting	Н	Н	OFF	OFF	ON
Un-Detecting	Un-Detecting	Detecting	Detecting	Н	L	OFF	OFF	ON
Un-Detecting	Un-Detecting	Detecting	Detecting	L	Н	OFF	OFF	ON
Un-Detecting	Un-Detecting	Detecting	Detecting	L	L	OFF	OFF	ON

- The above has indicated a part for single arm.
- There is no relevance of operation between arms.
- When the input of a high side arm and a low side arm is simultaneously set to "L", IGBT of a high side arm and a low side arm turns off.
- FO (X) terminal is turned on in the meantime at the same time, as for the output of Phase which detected the load short circuit state, it will maintain the OFF between 10 ms, if a Short Current Protection detects a Short Current state. Although an incoming signal is reset by an upper arm and a lower arm being simultaneously set to "H" in the back in this state, OFF of an output and FO (X) are maintained between 10 ms. Although FO (X) is turned off when FO (X) terminal for 10 ms will not be in the simultaneous "H" state of an upper arm and a lower arm in during ON time, an output maintains OFF. This release is made by an upper arm and a lower arm being simultaneously set to "H".
  - (Short current protection is a non-repetition. When FO (X) turns on, please turn off the input of all phase.)
- If an Over Temperature Protection circuit detects an Over Temperature state, while the output of Phase which detected the Over Temperature Protection state is turned off, FO (X) terminal turns it on. This state will return operation, if temperature falls to Over Temperature Protection detection return temperature (over temperature protection temperature over temperature protection hysteresis).

# Absolute Maximum Rating ( $T_j = 25^{\circ}C$ )

Characteristics	Symbol	Rating	Unit	
	$V_{BB}$	450	V	
Power supply voltage	V <sub>BB</sub> (surge)	500		
Tower supply voltage	V <sub>CC</sub>	20		
	V <sub>BS</sub>	20		
Collector-emitter voltage	V <sub>CES</sub>	600	V	
Each collector current (DC)	Ic	±10	Α	
Each collector current (PEAK)	I <sub>CP</sub>	±20	Α	
Input voltage	V <sub>IN</sub>	5.5	٧	
Fault output supply voltage	V <sub>FO</sub>	20	V	
Fault output current	I <sub>FO</sub>	15	mA	
PGND-SGND voltage difference	V <sub>PGND-SGND</sub>	±5	V	
Output voltage rate of change	dv/dt	20	kV/μs	
Collector power dissipation	Pc	43	W	
(per 1 IGBT chip) (Tc = 25°C)	FC	40	V V	
Collector power dissipation	Pc	25	W	
(per 1 FRD chip) (Tc = 25°C)	1 (;	25	VV	
Operating temperature	T <sub>OPE</sub>	-20 to 100	°C	
Junction temperature (Note 1)	Tj	150	°C	
Storage temperature	T <sub>stg</sub>	–40 to 125	°C	
Isolation voltage	V <sub>ISO</sub>	2500 (1 min)	Vrms	
(60 Hz sinusoidal, AC)	V ISO	2000 (1 111111)	VIIIIS	
Screw torque (M3)	_	0.5	N m	

Note 1: Although a junction temperature is 150°C the own maximum moment of a power chips which it builds in this module, the average operation junction temperature for carrying out safe operation specifies it as 125°C or less.

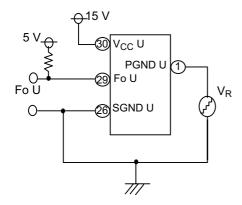


# Electrical Characteristics ( $T_j = 25^{\circ}C$ )

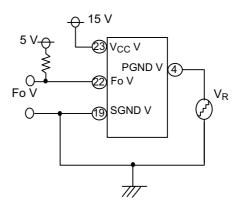
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit		
	$V_{BB}$	_	50	300	400	V		
Operating power supply voltage	V <sub>CC</sub>	_	13.5	15	17			
	V <sub>BS</sub>	_	13.5	15	17			
	I <sub>BB</sub>	V <sub>BB</sub> = 400 V, V <sub>IN</sub> = 5 V (1 arm)	_	_	1			
	Icc	V <sub>CC</sub> = 15 V, V <sub>IN</sub> = 5 V (1 arm)	_	0.8	1.5	mA		
Current dissipation		V <sub>CC</sub> = 15 V, V <sub>IN</sub> = 0 V (1 arm)	_	1.1	1.5	1		
	I <sub>BS</sub>	V <sub>CC</sub> = 15 V, V <sub>IN</sub> = 5 V (1 arm)	_	330	600	μА		
		V <sub>CC</sub> = 15 V, V <sub>IN</sub> = 0 V (1 arm)	_	470	1000			
	V <sub>IH</sub>	V <sub>IN</sub> = "H"	2.2	3.0	3.7	V		
Input voltage	V <sub>IL</sub>	V <sub>IN</sub> = "L"	2.2	3.0	3.7			
	I <sub>IH</sub>	V <sub>CC</sub> = 15 V, V <sub>IN</sub> = 5 V	0	5	30	<u> </u>		
Input current	I <sub>IL</sub>	V <sub>CC</sub> = 15 V, V <sub>IN</sub> = 0 V	15	30	60	μΑ		
IGBT saturation voltage	V <sub>sat</sub> U	V <sub>CC</sub> = 15 V, V <sub>BS</sub> = 15 V, I <sub>C</sub> = 10 A, upper arm		1.8	2.3	V		
	V <sub>sat</sub> L	V <sub>CC</sub> = 15 V, I <sub>C</sub> = 10 A, lower arm	_	1.8	2.3			
	V <sub>F</sub> U	I <sub>F</sub> = 10 A, upper arm		1.4	2.0	1		
FRD forward voltage	V <sub>F</sub> L	I <sub>F</sub> = 10 A, lower arm		1.4	2.0	V		
Fault output voltage	V <sub>FO</sub>	I <sub>FO</sub> = 5 mA		0.8	1.2	V		
Short current protection voltage	V <sub>R</sub>	Short current protection (Note 2)	1.16	1.28	1.41	V		
Short current protection delay time	V <sub>Rtd</sub>	Short current protection	1.0	1.5	2.0	μs		
Fault output pulse width	VRth	Short current protection		10		ms		
Over temperature protection	TSD	Over temperature protection	150	165	200	°C		
Over temperature protection hys.	ΔTSD	Over temperature protection return		20	_	°C		
Under voltage protection	V <sub>BS</sub> UVD	Upper arm under voltage protection	10.0	11.0	12.0	V		
Under voltage protection recovery	V <sub>BS</sub> UVR	Upper arm under voltage protection recovery	10.5	11.5	12.5	V		
Under voltage protection	V <sub>CC</sub> UVD	Lower arm under voltage protection	10.5	11.5	12.5	V		
Under voltage protection recovery	V <sub>CC</sub> UVR	Lower arm under voltage protection recovery	11.0	12.0	13.0	V		
IGBT turn-on propagation delay time	t <sub>dON</sub>			0.5	_	μs		
IGBT rise time	t <sub>r</sub>	-  		0.04	0.08	μs		
IGBT turn-on time	ton	$V_{BB} = 300 \text{ V},$ $V_{CC} = 15 \text{ V},$		0.5	0.9	μs		
IGBT turn-off propagation delay time	t <sub>dOFF</sub>	$-V_{BS} = 15 V,$ $I_{C} = 10 A,$		0.5	_	μs		
IGBT fall time	t <sub>f</sub>	inductive load (Note 3)		0.09	0.13	μs		
IGBT turn-off time	- T			0.6	1.0	μs		
IGBT vertical arm turn-on, a turn-off propagation delay time lag	t <sub>OFFL</sub>	V <sub>BB</sub> = 300 V, V <sub>CC</sub> = 15 V, V <sub>BS</sub> = 15 V, I <sub>C</sub> = 10 A, inductive load (include each phase)	_	0	300	ns		
IGBT vertical arm turn-on, a turn-off propagation delay time lag	toffl -	$V_{BB} = 300 \text{ V}, V_{CC} = 15 \text{ V}, V_{BS} = 15 \text{ V},$ $I_{C} = 10 \text{ A}, \text{ inductive load}$ (include each phase)	_	0	300	ns		
Daed time	t <sub>dead</sub>	$V_{BB} = 300 \text{ V}, V_{CC} = 15 \text{ V}, V_{BS} = 15 \text{ V},$ $I_{C} = 10 \text{ A,inductive load}$	1	_	_	μs		
FRD reverse recovery time	t <sub>rr</sub>	$V_{BB} = 300 \text{ V}, V_{CC} = 15 \text{ V}, V_{BS} = 15 \text{ V}, I_F = 10 \text{ A}$ (Note 3)		100	_	Ns		
Thormal registance	R <sub>th (j-c)</sub>	Transistor stage	_	_	2.9	°C/W		
Thermal resistance		Diode stage	_	_	5.0			

Note 2: V<sub>R</sub> measurement circuit

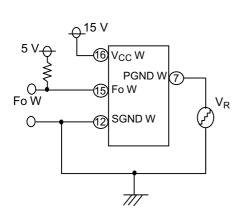
**U-Phase** 



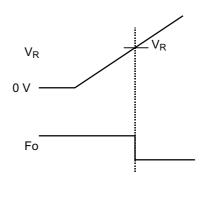




W-Phase



**Timing Chart** 

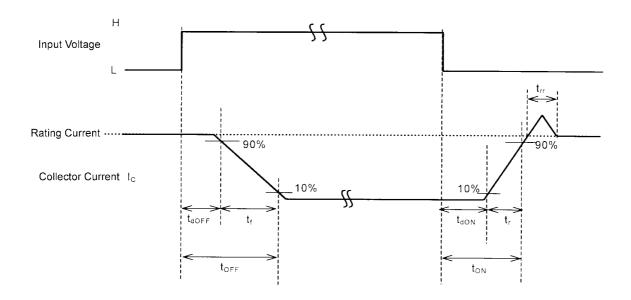


 $V_{\mbox{\scriptsize R}}$  is measured by giving the sweep voltage from the outside like the above-mentioned.

When the overcurrent detection value is set by an actual application, it is necessary to consider the resistance of the internal bonding wire.

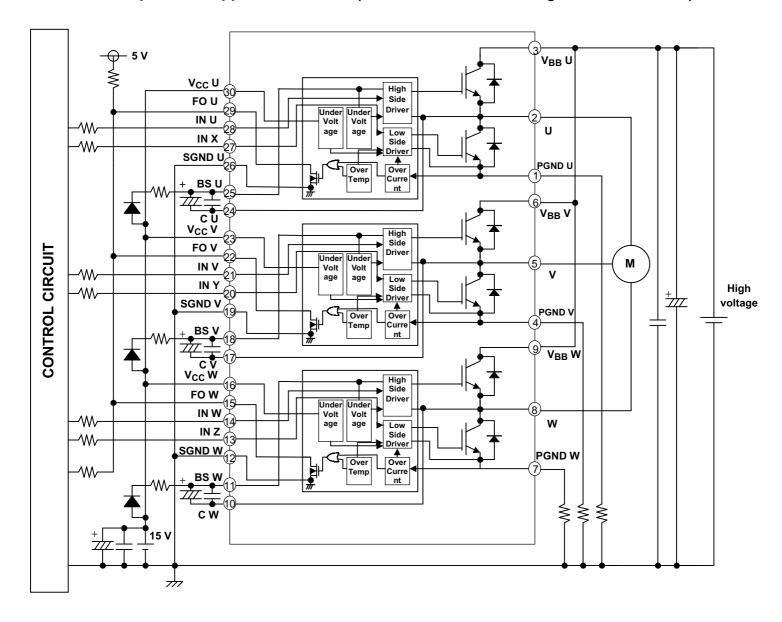
The resistance of the internal bonding wire is 11 m $\Omega$ .

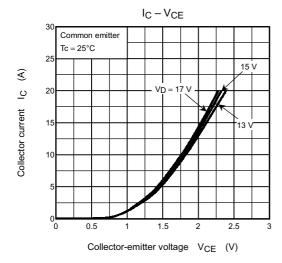
Note 3: Switching waveform

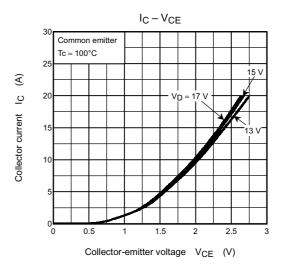


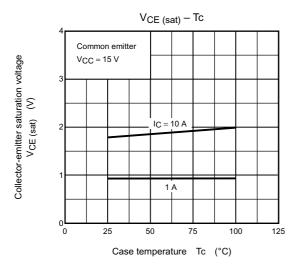
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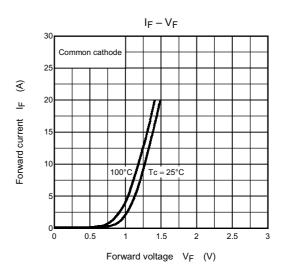
# The Example of an Application Circuit (in the case of not insulating with a control side)

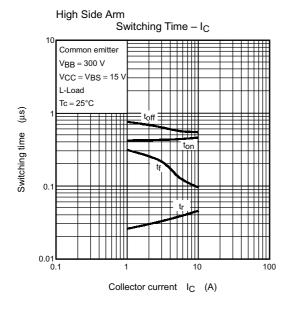


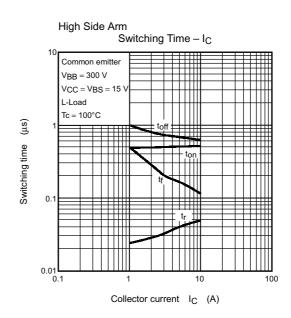


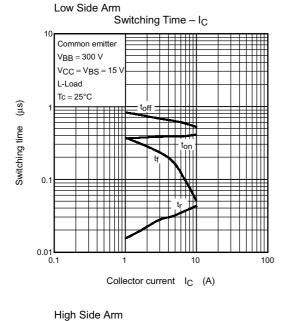


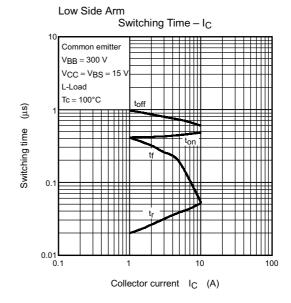


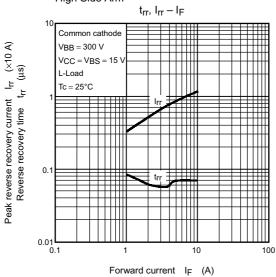


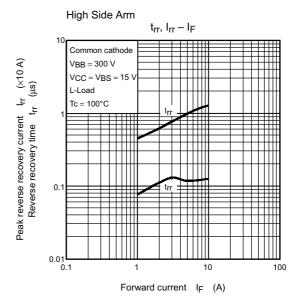


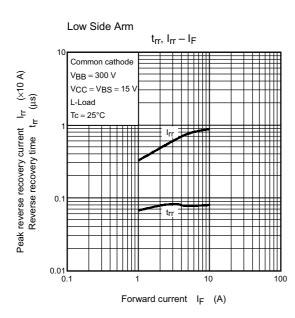


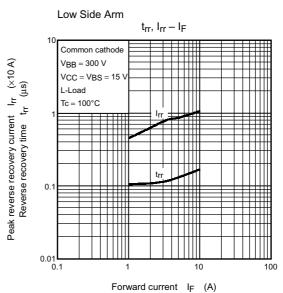


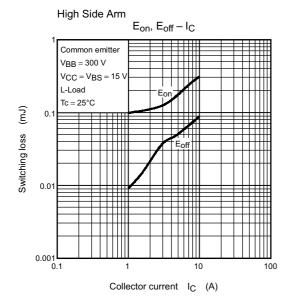


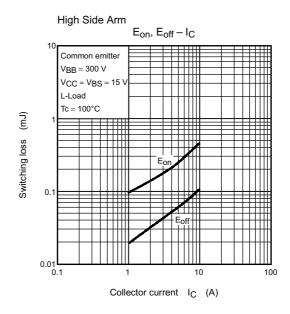


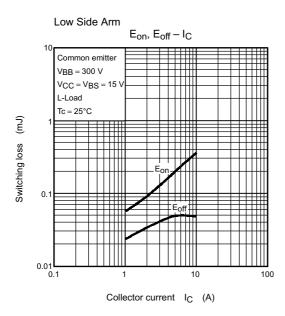


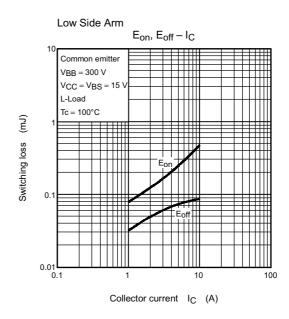


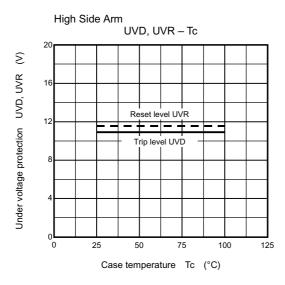


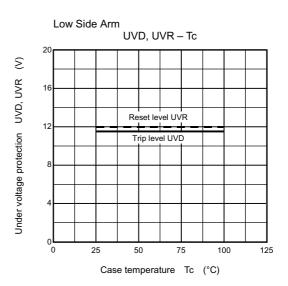


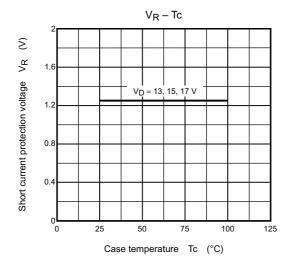


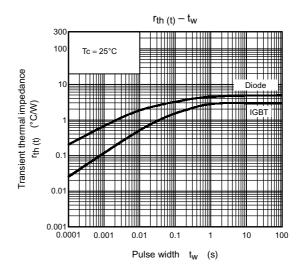






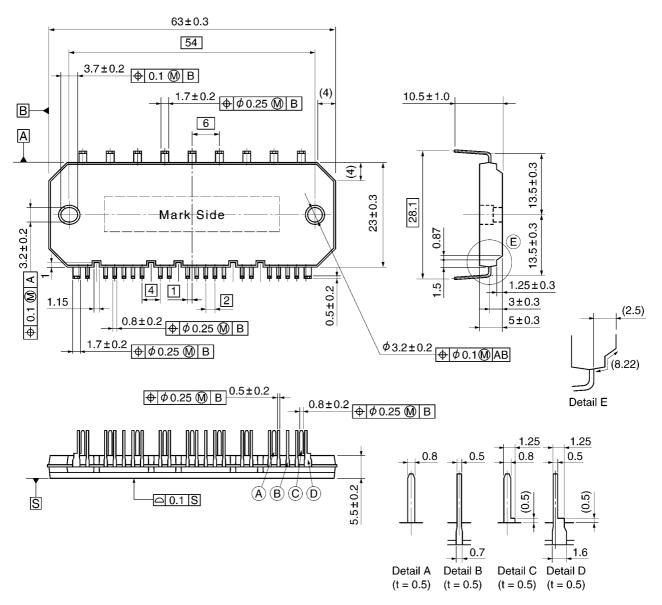






## Package Dimensions: TOSHIBA 2-63A1A

Unit: mm



14

Weight: 18 g (typ.)

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